

On the Stability-Plasticity Dilemma in Continual Meta-Learning: Theory and Algorithm

i Chen ¹ Changjian Shui ² Ligong Han ³ Mario Marchand ¹

¹Laval University, Canada, ²McGill University, Canada, ³Rutgers University, USA



Main Contribution

- Unified theoretical framework for continual meta-learning in both static and shifting task environments.
- Formal analysis of the bi-level learning-forgetting trade-off
- Theoretically grounded algorithm

Problem Setup

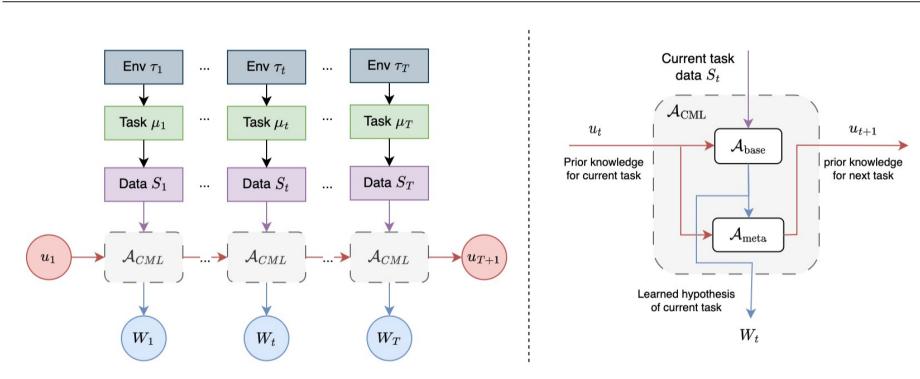


Figure 1. Illustration of Continual Meta-Learning (CML) process

- Base learner batch learning algorithms $W_t = \mathcal{A}(u_t, S_t), u_t \in \mathcal{U}$
- Excess Risk:
 - $R_{\text{excess}}(\mathcal{A}, u_t) \stackrel{\text{def}}{=} \mathbb{E}_{S_t} \mathbb{E}_{W_t \sim P_{W_t \mid S_t, u_t}} \left[\mathcal{L}_{\mu_t}(W_t) \mathcal{L}_{\mu_t}(w_t^*) \right], w_t^* = \arg\min_{w \in \mathcal{W}} \mathcal{L}_{\mu_t}(w).$
- meta-parameter $u_t = (\beta_t, \phi_t)$
- Unified form of excess risk upper bound for $A \in \{Gibbs, RLM, SGD, SGLD\}$:

$$f_t(u_t) = \kappa_t \left(a\beta_t + \frac{b\|\phi_t - w_t\|^2 + \epsilon_t + \epsilon_0}{\beta_t} + \Delta_t \right), \ \kappa_t, \epsilon_t, \beta_t, \Delta_t \in \mathbb{R}^+, \ \forall t \in [T], a, b, \epsilon_0 > 0.$$

- f_t is **convex**
- Meta learner online learning algorithms
- dynamic regret for N static slots

$$R_T^{\text{dynamic}}(u_{1:N}^*) \stackrel{\text{def}}{=} \sum_{n=1}^N \sum_{k=1}^{M_n} \left[f_{n,k}(u_{n,k}) - f_{n,k}(u_n^*) \right], u_n^* \stackrel{\text{def}}{=} \arg\min_u \frac{1}{M_n} \sum_{k=1}^{M_n} f_{n,k}(u).$$

- Continual meta-learning objective
- select $u_{1:T}$ to minimize the Average Excess Risk (AER):

$$AER_{\mathcal{A}}^{T} \stackrel{\text{\tiny def}}{=} \frac{1}{T} \sum_{t=1}^{T} R_{\text{excess}}(\mathcal{A}, u_{t}) \leq \frac{1}{T} R_{T}^{\text{dynamic}}(u_{1:N}^{*}) + \frac{1}{T} \sum_{n=1}^{N} \sum_{k=1}^{M_{n}} f_{n,k}(u_{n}^{*}).$$

DCML Algorithm

- \equiv For any timestep $t \in [T]$
- Sample task distribution $\mu_t \sim \tau_t$, Sample dataset $S_t \sim \mu_t$;
- Get meta parameter $u_t = (\beta_t, \phi_t)$, learn base parameter $w_t = \mathcal{A}(u_t, S_t)$, estimate $f_t(u_t)$
- Adjust the learning rate of the meta-parameter (γ_t) with the following strategy:
- When an environment change is detected, γ_t is set to a large hopping rate $\gamma_t = \rho$
- For k-th task inside the n-th environment (slot), $\gamma_t = \gamma_0/\sqrt{k}$
- Update meta parameter $u_{t+1} = \Pi_{\mathcal{U}}(u_t \gamma_t \nabla f_t(u_t)), i.e.,$

$$\phi_{t+1} = \left(1 - \frac{2b\kappa_t \gamma_t}{\beta_t}\right)\phi_t + \frac{2b\kappa_t \gamma_t}{\beta_t}w_t, \beta_{t+1} = \beta_t - \gamma_t \left(a\kappa_t - \frac{\kappa_t(b\|\phi_t - w_t\|^2 + \epsilon_t + \epsilon_0)}{\beta_t^2}\right)$$

Contact Information

- Email: qi.chen.1@ulaval.ca
- Code: https://github.com/livreQ/DynamicCML

Bi-level Learning-Forgetting Trade-off

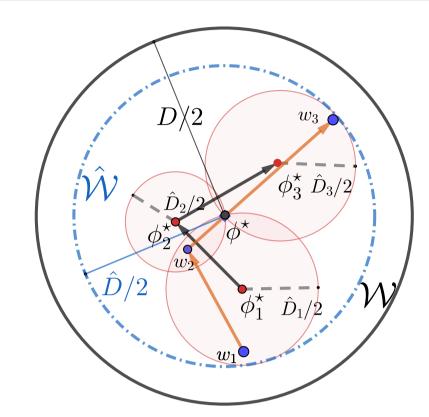


Figure 2. Illustration of a shifting environment.

- task-level learning-forgetting trade-off
- two tasks $||w_1 w_2|| > \hat{D}_1/2$
- directly adapt
- => catastrophic forgetting
- keep the optimal prior ϕ_n^* => no forgetting $\|\phi_1^* - w_1\| < \hat{D}_1/2$ and $\|\phi_1^* - w_2\| < \hat{D}_1/2$
- D_n => \uparrow number of examples to recover performance
- meta-level learning-forgetting trade-off
- large environment shift $\hat{D} \gg \hat{D}_n$
- ↑ learning rate of meta-knowledge
- ↑ forgetting meta-knowledge inside slots

Main Theorem

Theorem 1 (Simplified) Consider both **static** and **shifting** environments. If the excess risk's upper bound of the base learner $\mathcal{A}(u_t, S_t)$ can be formulated as the unified form, then, the **AER** of **DCML** is upper bounded by:

$$AER_{\mathcal{A}}^{T} \leq \underbrace{\frac{2}{T} \sum_{n=1}^{N} \sqrt{a(bV_{n}^{2} + \epsilon_{n} + \epsilon_{0})} \kappa_{n} + \frac{\Delta_{n}}{2}}_{\text{optimal trade-off in hindsight}} + \underbrace{\frac{3}{2T} \sum_{n=1}^{N} \tilde{D}_{n} G_{n} \sqrt{M_{n} - 1}}_{\text{average regret over slots}} + \underbrace{\frac{\tilde{D}_{\text{max}}}{T} \sqrt{2P^{*} \sum_{n=1}^{N} G_{n}^{2}}}_{\text{regret w.r.t environment shift}},$$

where subscript n, k indicate k-th task in n-th slot, $\epsilon_n, \epsilon_0, \kappa_n$ are related to sample number for each task, $P^* = \sum_{n=1}^{N-1} \|u_n^* - u_{n+1}^*\| + 1$ is the path length.

- Optimal trade-off \leq average of slot variances V_n^2 (task similarities)
- Task-level regret <=> slot diameters \tilde{D}_n (task similarities)
- Environment-level regret $\langle = \rangle$ path length P^* (environment similarities, non-stationarity)

AER Bounds of Specific Base Learners

Theorem 2 (Gibbs Algorithm, simplified) Apply Gibbs algorithm as the base learner in **DCML** and further assume that each slot has equal length M and each task uses the sample number m. Then, the AER can be bounded by:

$$AER_{Gibbs}^T \le \mathcal{O}\left(1 + \bar{V} + \frac{\sqrt{MN} + \sqrt{P^*}}{M\sqrt{N}}\right) \frac{1}{m^{\frac{1}{4}}}, \bar{V} \stackrel{\text{def}}{=} \frac{1}{N} \sum_{n=1}^N V_n.$$

- Single-task learning $\mathcal{O}\left((D+1)m^{-1/4}\right)$
- Static environments $\mathcal{O}((V+1)m^{-1/4})$ with rate $\mathcal{O}(1/\sqrt{T})$,
- Shifting environments $\mathcal{O}((\bar{V}+1)m^{-1/4})$ with rate $\mathcal{O}(1/\sqrt{M}), \, \bar{V} \leq V \leq \hat{D} \leq D$
- \blacksquare => Same AER with a smaller M, i.e., faster-constructing meta-knowledge in new environments.

Theorem 3 (Stochastic Gradient Descent(SGD), simplified) Apply SGD as the base learner in \mathbf{DCML} and further assume that each slot has equal length M and each task uses the sample number m. Then, the AER can be bounded by:

$$AER_{SGD}^{T} \leq \mathcal{O}\left(\bar{V} + \frac{\sqrt{MN} + \sqrt{P^*}}{M\sqrt{N}}\right)\sqrt{\frac{1}{K} + \frac{1}{m}}, \bar{V} \stackrel{\text{def}}{=} \frac{1}{N}\sum_{n=1}^{N} V_n.$$

- Static environment
- $N = 1, P^* = 1, M = T$
- recover static regret $\mathcal{O}(V + \frac{1}{\sqrt{T}})\sqrt{\frac{1}{K} + \frac{1}{m}}$
- Shifting environment
- When N is small and P^* is large
- better than $\mathcal{O}(\bar{V} + \frac{1}{\sqrt{M}} + \sqrt{\frac{P^*}{NM}})$

Experiments

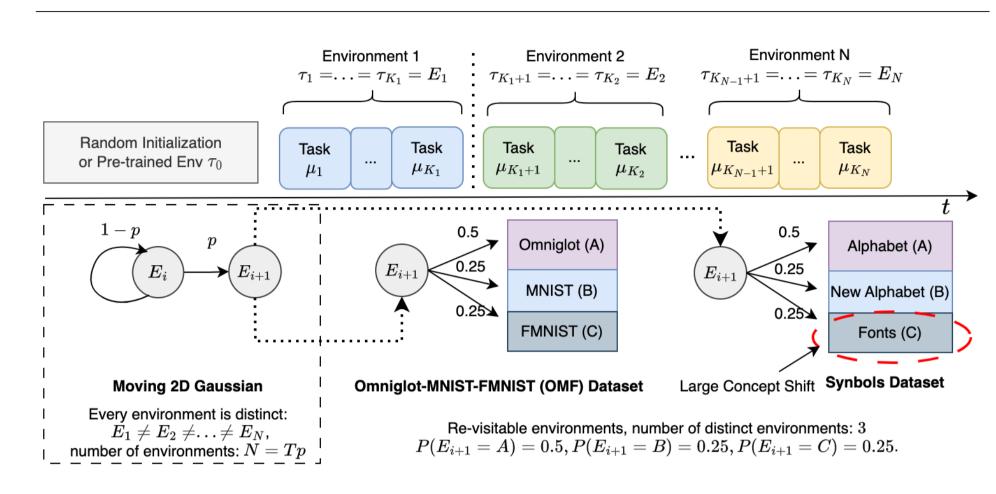


Figure 3. Illustration of the CML experimental setting on synthetic and real datasets. At each time t, the environment changes with probability p. If current environment is $\tau_t = E_i$, the next environment $P(\tau_{t+1} = E_{i+1}) = p$, $P(\tau_{t+1} = E_i) = 1 - p$.

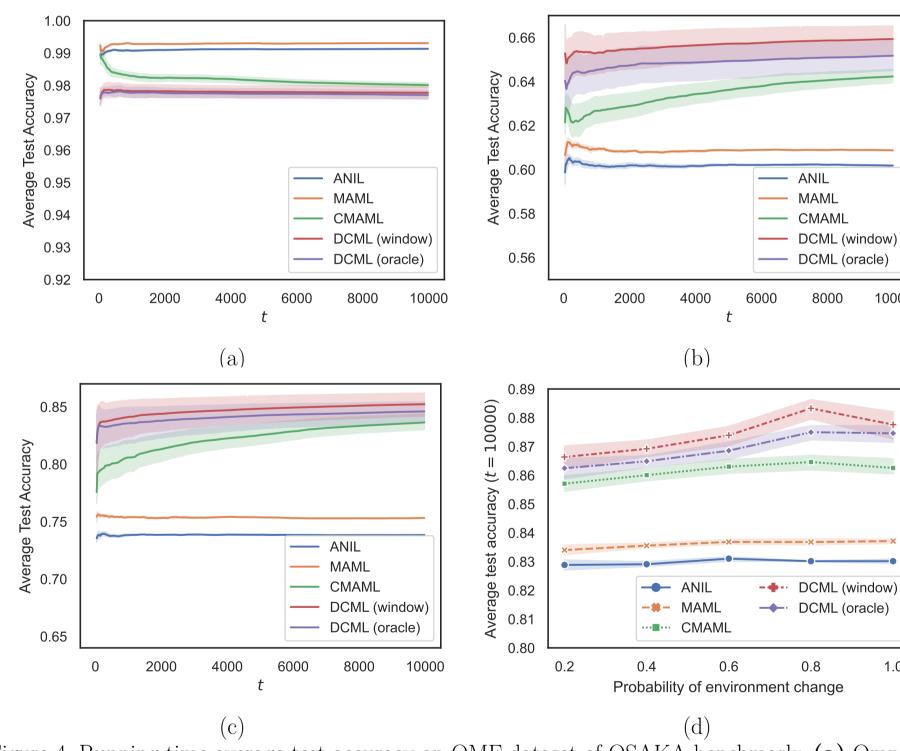


Figure 4. Running time average test accuracy on OMF dataset of OSAKA benchmark: (a) Omniglot (pre-trained environment), (b) FashionMNIST and (c) MNIST, where the environment shifts with probability p = 0.2. (d) Average test accuracy on overall environment at final step t = 10000 w.r.t p.

- better overall learning-forgetting trade-off
- stable to different levels of non-stationarity
- no need for precise environment shifts detection





